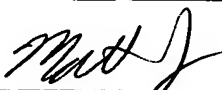




FORM PTO-1449		DOCKET NO: 60919 (70551)		SERIAL NO.: 10/789,085			
INFORMATION DISCLOSURE STATEMENT		APPLICANT(S): Tetsuya INUI, et al.					
		FILING DATE: February 27, 2004		GROUP NO.: Not Yet Assigned			
UNITED STATES PATENT DOCUMENTS							
EXAM. INITIALS		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
FOREIGN PATENT DOCUMENTS							
		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES/NO
M)	BA	11-307450	11/05/99	JAPAN	H01L	21/20	ABSTRACT
M)	BB	58-201326	11/24/83	JAPAN	H01L	21/26	ABSTRACT
M)	BC	WO 97/45827	12/04/97	PCT	G09G	3/36	YES
OTHER DOCUMENTS (INCLUDING AUTHOR, TITLE, DATE, PERTINENT PAGES, ETC.)							
M)	CA	Akito Hara, et al., "Nucleus Formation Site of Silicon on Glass and Solidification Direction Control - Aiming to Form Monocrystalline Silicon Si-TFT" Textbook of the 112 th workshop of Division of Materials Science and Crystal Technology of the Japan Society of Applied Physics, Division of Materials Science and Crystal Technology of the Japan Society of Applied Physics, pp. 19-25 (2000).					
EXAMINER: 				DATE: 3/16/06			



REPLACEMENT 1449 FORM

FORM PTO-1449 INFORMATION DISCLOSURE STATEMENT	DOCKET NO: 60919 (70551)	SERIAL NO.: 10/789,085
	APPLICANT(S): Tetsuya INUI, et al.	
	FILING DATE: February 27, 2004	GROUP NO.: Not Yet Assigned

UNITED STATES PATENT DOCUMENTS


EXAM. INITIALS		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE

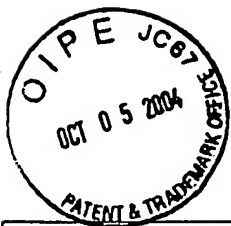
FOREIGN PATENT DOCUMENTS

		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES/NO
M)	BA	11-307450	11/05/99	JAPAN	H01L	21/20	ABSTRACT
M)	BB	58-201326	11/24/83	JAPAN	H01L	21/26	ABSTRACT
M)	BC	2000-505241	04/25/00	JAPAN	H01L	21/20	NO

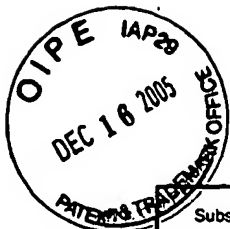
OTHER DOCUMENTS (INCLUDING AUTHOR, TITLE, DATE, PERTINENT PAGES, ETC.)

M)	CA	Akito Hara, et al., "Nucleus Formation Site of Silicon on Glass and Solidification Direction Control - Aiming to Form Monocrystalline Silicon Si-TFT" Textbook of the 112 th workshop of Division of Materials Science and Crystal Technology of the Japan Society of Applied Physics, Division of Materials Science and Crystal Technology of the Japan Society of Applied Physics, pp. 19-25 (2000).

EXAMINER: 	DATE: 3/16/2006
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INFORMATION DISCLOSURE STATEMENT		APPLICANT(S): Tetsuya INUI, et al.					
		FILING DATE: February 27, 2004		GROUP NO.: Not Yet Assigned			
UNITED STATES PATENT DOCUMENTS							
EXAM. INITIALS		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
FOREIGN PATENT DOCUMENTS							
		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES/NO
(h)	BA	WO 97/45827	12/04/97	PCT	G09G	3/36	YES
OTHER DOCUMENTS (INCLUDING AUTHOR, TITLE, DATE, PERTINENT PAGES, ETC.)							
EXAMINER: <i>Math J</i>					DATE: <i>3/16/2006</i>		



PTO/SB/08a/b (07-05)

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Substitute for form 1449A/B/PTO				Complete if Known	
INFORMATION DISCLOSURE STATEMENT BY APPLICANT <i>(Use as many sheets as necessary)</i>				Application Number	10/789,085-Conf. #7533
				Filing Date	February 27, 2004
				First Named Inventor	Tetsuya Inui
				Art Unit	1722
				Examiner Name	M. A. Anderson
Sheet	1	of	1	Attorney Docket Number	60919(70551)

U.S. PATENT DOCUMENTS					
Examiner Initials*	Cite No. ¹	Document Number Number-Kind Code ² (if known)	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear
IVIS	AA*	US-6,451,631-B1	09-17-2002	Grigoropoulos et al.	

FOREIGN PATENT DOCUMENTS						
Examiner Initials*	Cite No. ¹	Foreign Patent Document Country Code ³ -Number ⁴ -Kind Code ⁵ (if known)	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear	T ⁶
MS	BA	KR-2002-14704	02-25-2002			
MS	BB	JP-08-293466	11-05-1996			✓

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NON PATENT LITERATURE DOCUMENTS			
Examiner Initials	Cite No. ¹	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.	T ²

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¹ Applicant's unique citation designation number (optional). ² Applicant is to place a check mark here if English language Translation is attached.

Examiner Signature	<i>Mad J</i>	Date Considered	3/16/2006
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